

### FP9240-VB Datasheet

### **Power MOSFET**

PRODUCT SUMMARY						
V <sub>DS</sub> (V) - 100						
R <sub>DS(on)</sub> (Ω)	V <sub>GS</sub> = - 10 V	V <sub>GS</sub> = - 10 V 0.20				
Q <sub>g</sub> (Max.) (nC)	6	61				
Q <sub>gs</sub> (nC)	1	14				
Q <sub>gd</sub> (nC)	2	29				
Configuration	Sin	Single				

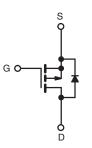
#### **FEATURES**

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- P-Channel
- Isolated Central Mounting Hole
- 175 °C Operating Temperature
- Fast Switching
- Ease of Paralleling
- Compliant to RoHS Directive 2002/95/EC



TO-247AC





P-Channel MOSFET

PARAMETER	SYMBOL	LIMIT	UNIT	
Drain-Source Voltage	$V_{DS}$	- 100	V	
Gate-Source Voltage	$V_{GS}$	± 20	V	
Continuous Drain Current	$V_{GS}$ at - 10 V $T_{C} = 25 ^{\circ}\text{C}$ $T_{C} = 100 ^{\circ}\text{C}$	I_	- 21	
Continuous Drain Guirent	$V_{GS} \text{ at - 10 V} T_{C} = 100 ^{\circ}\text{C}$	- ID	- 15	Α
Pulsed Drain Current <sup>a</sup>	I <sub>DM</sub>	- 84		
Linear Derating Factor		1.2	W/°C	
Single Pulse Avalanche Energy <sup>b</sup>	E <sub>AS</sub>	960	mJ	
Repetitive Avalanche Current <sup>a</sup>	I <sub>AR</sub>	- 21	Α	
Repetitive Avalanche Energy <sup>a</sup>		E <sub>AR</sub>	18	mJ
Maximum Power Dissipation	$P_{D}$	180	W	
Peak Diode Recovery dV/dtc	dV/dt	- 5.5	V/ns	
Operating Junction and Storage Temperature Rang	T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 175	°C	
Soldering Recommendations (Peak Temperature)	for 10 s		300 <sup>d</sup>	1
Mounting Torque	6-32 or M3 screw		10	lbf ⋅ in
Wounting Torque	0-32 of M3 screw		1.1	N⋅m

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b.  $V_{DD} = -25$  V, starting  $T_J = 25$  °C, L = 3.3 mH,  $R_g = 25$   $\Omega$ ,  $I_{AS} = -21$  A (see fig. 12). c.  $I_{SD} \le -21$  A,  $dI/dt \le 200$  A/ $\mu$ s,  $V_{DD} \le V_{DS}$ ,  $T_J \le 175$  °C. d. 1.6 mm from case.

<sup>\*</sup> Pb containing terminations are not RoHS compliant, exemptions may apply



THERMAL RESISTANCE RATINGS						
PARAMETER SYMBOL TYP. MAX. UNIT						
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	40			
Case-to-Sink, Flat, Greased Surface	R <sub>thCS</sub>	0.24	-	°C/W		
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	0.83			

PARAMETER	SYMBOL	TEST	MIN.	TYP.	MAX.	UNIT	
Static					•		
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_{D} = -250 \mu\text{A}$		- 100	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference to	o 25 °C, I <sub>D</sub> = - 1 mA	-	- 0.087	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{C}$	<sub>SS</sub> , I <sub>D</sub> = - 250 μA	- 2.0	-	- 4.0	V
Gate-Source Leakage	I <sub>GSS</sub>	V <sub>G</sub>	<sub>S</sub> = ± 20 V	-	-	± 100	nA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>		V <sub>DS</sub> = - 100 V, V <sub>GS</sub> = 0 V V <sub>DS</sub> = - 80 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 150 °C		-	- 100 - 500	μA
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	-	I <sub>D</sub> = - 13 A <sup>b</sup>	-	0.20	-	Ω
Forward Transconductance	9 <sub>fs</sub>	V <sub>DS</sub> = - 5	60 V, I <sub>D</sub> = - 13 A <sup>b</sup>	6.2	-	-	S
Dynamic						l.	
Input Capacitance	C <sub>iss</sub>	V	<sub>GS</sub> = 0 V.	-	1400	-	
Output Capacitance	C <sub>oss</sub>	$V_{D}$	S = - 25 V,	-	590	-	рF
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1.0	f = 1.0 MHz, see fig. 5		140	-	1
Total Gate Charge	Qg			-	-	61	
Gate-Source Charge	Q <sub>gs</sub>	V <sub>GS</sub> = - 10 V	I <sub>D</sub> = -19 A, V <sub>DS</sub> = -80 V, see fig. 6 and 13 <sup>b</sup>	-	-	14	nC
Gate-Drain Charge	Q <sub>gd</sub>		see lig. 0 and 10		-	29	1
Turn-On Delay Time	t <sub>d(on)</sub>	$V_{DD} = \text{-} 50 \text{ V, } I_D = \text{-} 19 \text{ A,}$ $R_g = 9.1 \ \Omega, \ R_D = 2.4 \ \Omega, \ \text{see fig. } 10^b$		-	16	-	ns ns
Rise Time	t <sub>r</sub>			-	73	-	
Turn-Off Delay Time	t <sub>d(off)</sub>			-	34	-	
Fall Time	t <sub>f</sub>			-	57	-	
Internal Drain Inductance	$L_D$	Between lead, 6 mm (0.25") from package and center of die contact		-	5.0	-	
Internal Source Inductance	L <sub>S</sub>			-	13	-	- nH
Drain-Source Body Diode Characteristic	s				•		
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		ı	-	- 21	- A
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			-	_	- 84	
Body Diode Voltage	$V_{SD}$	$T_{J} = 25  ^{\circ}\text{C},  I_{S} = -21  \text{A},  V_{GS} = 0  \text{V}^{\text{b}}$		ı	-	- 5.0	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	T <sub>J</sub> = 25 °C, I <sub>F</sub> = -19 A, dl/dt = 100 A/μs <sup>b</sup>		-	130	260	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			-	0.35	0.70	μC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-on time is negligible (turn-on is dominated by L <sub>S</sub> and L <sub>D</sub> )				LD)	

### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width  $\leq$  300  $\mu$ s; duty cycle  $\leq$  2 %.



### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

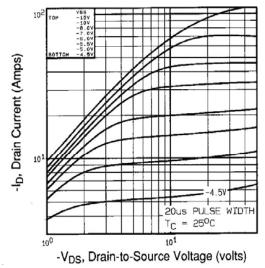
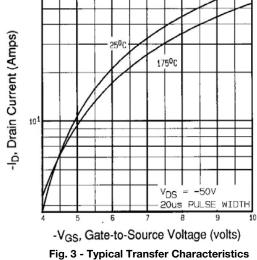


Fig. 1 - Typical Output Characteristics,  $T_C = 25$  °C



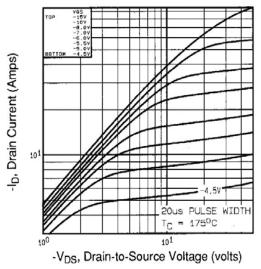


Fig. 2 - Typical Output Characteristics,  $T_C$  = 175  $^{\circ}C$ 

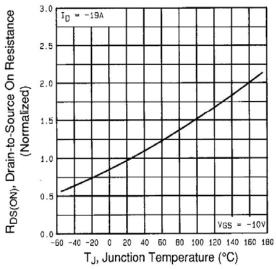


Fig. 4 - Normalized On-Resistance vs. Temperature



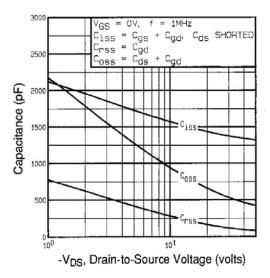


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

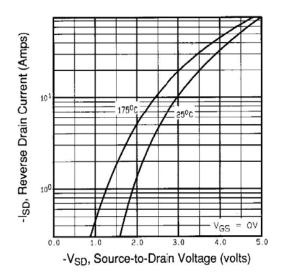


Fig. 7 - Typical Source-Drain Diode Forward Voltage

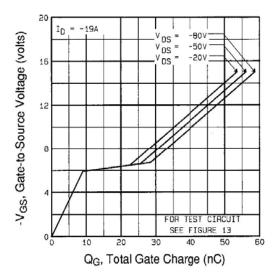


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

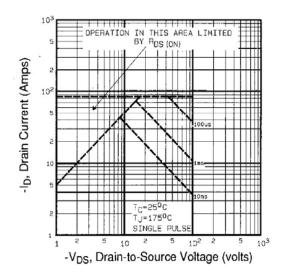


Fig. 8 - Maximum Safe Operating Area



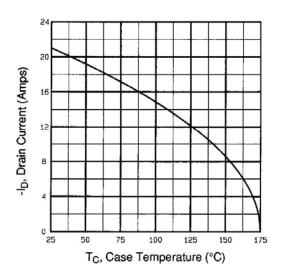


Fig. 9 - Maximum Drain Current vs. Case Temperature

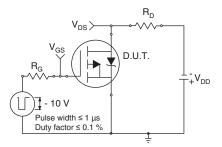


Fig. 10a - Switching Time Test Circuit

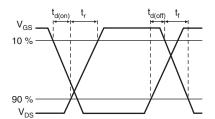


Fig. 10b - Switching Time Waveforms

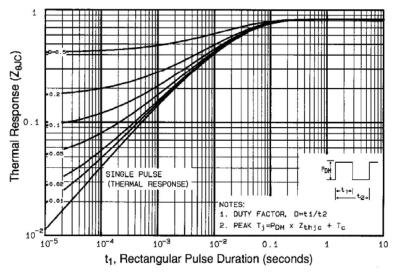
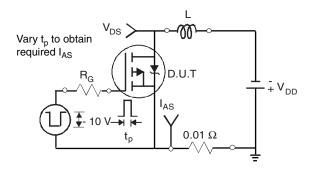
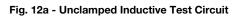


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case







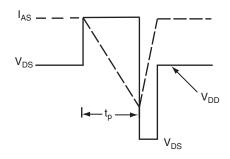


Fig. 12b - Unclamped Inductive Waveforms

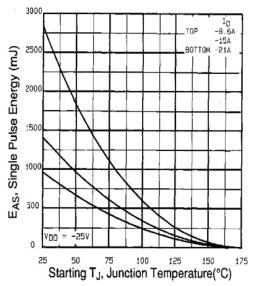


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

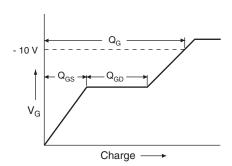


Fig. 13a - Basic Gate Charge Waveform

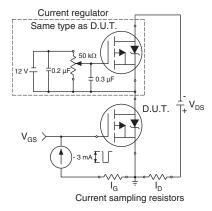
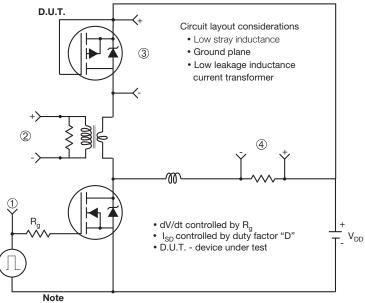


Fig. 13b - Gate Charge Test Circuit



### Peak Diode Recovery dV/dt Test Circuit



• Compliment N-Channel of D.U.T. for driver

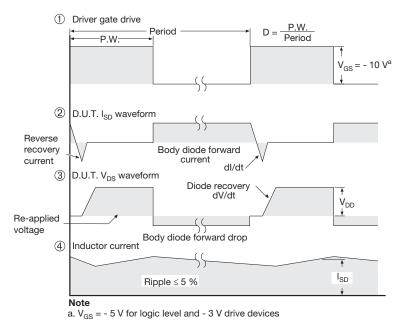
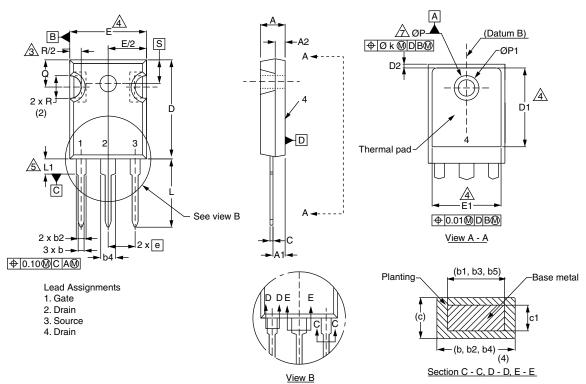


Fig. 14 - For P-Channel



# **TO-247AC (High Voltage)**



	MILLIMETERS		INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
Α	4.58	5.31	0.180	0.209
A1	2.21	2.59	0.087	0.102
A2	1.17	2.49	0.046	0.098
b	0.99	1.40	0.039	0.055
b1	0.99	1.35	0.039	0.053
b2	1.53	2.39	0.060	0.094
b3	1.65	2.37	0.065	0.093
b4	2.42	3.43	0.095	0.135
b5	2.59	3.38	0.102	0.133
С	0.38	0.86	0.015	0.034
c1	0.38	0.76	0.015	0.030
D	19.71	20.82	0.776	0.820
D1	13.08	-	0.515	-

	MILLIMETERS		INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
D2	0.51	1.30	0.020	0.051
E	15.29	15.87	0.602	0.625
E1	13.72	-	0.540	-
е	5.46 BSC		0.215 BSC	
Øk	0.254		0.010	
L	14.20	16.25	0.559	0.640
L1	3.71	4.29	0.146	0.169
N	7.62 BSC		0.300	BSC
ØΡ	3.51	3.66	0.138	0.144
Ø P1	-	7.39	-	0.291
Q	5.31	5.69	0.209	0.224
R	4.52	5.49	0.178	0.216
S	5.51 BSC		0.217	BSC

ECN: X13-0103-Rev. D, 01-Jul-13

DWG: 5971

#### **Notes**

- 1. Dimensioning and tolerancing per ASME Y14.5M-1994.
- 2. Contour of slot optional.
- 3. Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm (0.005") per side. These dimensions are measured at the outermost extremes of the plastic body.
- 4. Thermal pad contour optional with dimensions D1 and E1.
  5. Lead finish uncontrolled in L1.
- 6. Ø P to have a maximum draft angle of 1.5 to the top of the part with a maximum hole diameter of 3.91 mm (0.154").
- 7. Outline conforms to JEDEC outline TO-247 with exception of dimension c.
- 8. Xian and Mingxin actually photo.



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